

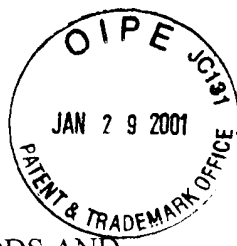
IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Satya et al

Application No.: 09/648,381

Filed: August 25, 2000

Title: MULTI-PIXEL METHODS AND
APPARATUS FOR ANALYSIS OF DEFECT
INFORMATION FROM TEST STRUCTURES ON
SEMICONDUCTOR DEVICES



Attorney Docket No.: KLA1P016G

Examiner: Not assigned

Group: 2881

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CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the
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Signed: 

Yvette Black

INFORMATION DISCLOSURE STATEMENT
UNDER 37 CFR §§1.56 AND 1.97(c)

Assistant Commissioner for Patents
Washington, DC 20231

Dear Sir:

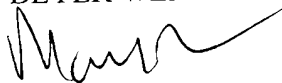
The references listed in the attached PTO Form 1449, copies of which are attached, may be material to examination of the above-identified patent application. Applicants submit these references in compliance with their duty of disclosure pursuant to 37 CFR §§1.56 and 1.97. The Examiner is requested to make these references of official record in this application.

This Information Disclosure Statement is not to be construed as a representation that a search has been made, that additional information material to the examination of this application does not exist, or that these references indeed constitute prior art.

This Information Disclosure Statement is believed to be filed before the mailing date of a first Office Action on the merits. Accordingly, it is believed that no fees are due in connection with the filing of this Information Disclosure Statement. However, if it is determined that any fees are due, the Commissioner is hereby authorized to charge such fees to Deposit Account 500388 (Order No. KLA1P016G).

Respectfully submitted,

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